Tests of MVD Prototype Pad Detector with a β^- Source

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Abstract

The MVD group has been testing two versions of silicon pad detectors. One design uses a single metal layer for readout trace routing. The second type uses two layers of metal, allowing for greatly simplified signal routing. However, because the readout traces for the pads pass over the other pads in the same column (separated by an oxide layer), the double-metal design introduces crosstalk into the system. A simple test stand using a 90 Sr β^{-} source with scintillator triggers was made to estimate the crosstalk. The crosstalk between pads in the same column of the pad detector was 1.6 – 3.1%. The values measured between pads in different columns were very close to zero. The measured crosstalk was below our maximum allowed value of 7.8%.

I. INTRODUCTION

The Relativistic Heavy-Ion Collider (RHIC) is a nucleus-nucleus collider being built at Brookhaven National Laboratory. It is capable of accelerating gold nuclei to 100 GeV/nucleon in each direction. PHENIX [1,2] is one of the four major experiments at RHIC that will look for experimental evidence of a phase transition to and from a quarkgluon plasma, a form of matter thought to have existed at the beginning of the Universe. The colliding beams are parallel to the axis of the Multiplicity Vertex Detector (MVD), which is in the center of the PHENIX experiment, surrounding the region where the two beams collide. The MVD includes silicon strip detectors arranged in two concentric barrels, with strips running perpendicular to the beam axis. The endcaps are an arrangement of silicon pad detectors and extend the range of angular distribution measurements. The MVD measures the charged-particle distribution event-by-event, provides event characterization and a centrality trigger to the PHENIX experiment. Simulations indicate that correlating the hits in the two-barrels allows one to determine the vertex of the collision in three dimensions with a several hundred micron resolution. The segmentation of the pad detectors also allows the study of fluctuations in charged particle multiplicity, a signature of the formation of a quark-gluon plasma. Details of the Multiplicity Vertex Detector are presented elsewhere |3-5|.

The PHENIX MVD group has been testing two types of silicon pad detectors for the "endcaps" of the MVD [6] (see Fig. 1). One design, "single-metal", has traces which take the signals from the pads (i.e. the keystone shaped counting elements which collect the charge) to the edges of the detector wafers. To prevent the traces from crossing, they are brought to 3 of the 4 edges of the detector wafer. These traces are in the same metallic plane as the pads. The signals would be connected to the electronics via relatively complex cable which overlays the detector wafer, and routes all signals to the top of the detector. The "single metal" design is more conventional and is historically the technology employed in silicon detectors. The MVD would like to use the newer and more "cutting-edge" technology of the

"double metal" design. The "double metal" design has many advantages over the traditional "single metal" design: eliminates the need of a specialized kapton cable for readout, reduces the amount of wirebonding, facilitates detector probing, facilitates assembly and handling, therefore increasing yield, and allows for a sequential readout. The routing is much simpler if a "double-metal" detector design is used. In this design the traces which take the signals to the edge of the detector are separated from the pads by an oxide (SiO_2) layer [7]. The traces go from the pads, through the oxide layer, to a second "metal" layer. The signal traces can then all be brought to the top edge of the detector, eliminating the cable overlays of the single-metal design. However, there was some concern that the coupling through the capacitors formed by the traces from one pad crossing above the pads for other channels would introduce crosstalk into the system. In the study described here, we have measured the crosstalk in a prototype double-metal pad detector.

We established a limit on the amount of crosstalk which is acceptable by considering the effects of crosstalk of the pad detector trigger for central Au+Au events using a Monte Carlo simulation of the MVD with Hijing [8,9] events as input. The average occupancy of the pad detector pads in this case was $\approx 16\%$. The discriminator thresholds on each pad, used in the trigger, will be set at about 0.25 times the average signal from a minimumionizing particle (mip). There are 21 pads in each "column" of pads. A column is a set of pads at the same azimuthal angle, but different radial distances from the beam. The signal traces in the double metal design all run to the top (largest radial distance from the beam) edge of the pad detector. This means that the top pad has 20 signal traces crossing it and that the bottom pad's readout trace crosses over 20 other pads. If there is crosstalk between each pad in a column and the 20 other pads in the column, we would like the total crosstalk contribution to a pad without a hit to be small enough to avoid triggering the pad's discriminator. That is, we would like $(occupancy=0.16)^*(20 \text{ pads in column contributing})$ to crosstalk)*(crosstalk)*(average signal per particle=1 mip) to be less than 0.25 mip. This gives a limit on the crosstalk of: crosstalk < 0.25/(20*0.16) = 7.8%. Correction for crosstalk can be made in data analysis, but it is preferable to have a crosstalk level significantly below

II. TEST STAND

A. Cabling convention and front end electronics

The double-metal silicon pad detector we have studied has 21 rows and 12 columns, for a total of 252 channels. Figure 1 shows the configuration of the silicon pad detector. The size of the readout pads is different row by row, which increases as the radial distance increases. Eight channels out of 252 channels were wire-bonded to the front-end electronics (FEE) since we used a FEE board containing a single BVX pre-amplifier chip [10] with eight channels. Figure 2 shows the wire-bonded channels in this test and their respective cabling numbers to the FEE. The size of each readout pad is exaggerated. Channel 1,2,3 are 2.0mm \times 2.0mm, channel 4,5 are 2.5mm \times 2.5mm, channel 6 is 4.0mm \times 4.0mm, and channel 7,8 are 4.5mm \times 4.5mm respectively. Channel 1 through 5 sit in the same column and channel 6 through 8 are in the neighboring column. Therefore, the readout traces for channels 1–5 do not cross above the pads for channels 6–8 and vice-versa.

B. Beta source

⁹⁰Sr has a half-life 28.74 years. It beta decays to ⁹⁰Y with a 546.2keV beta end point energy. ⁹⁰Y is also unstable and decays to ⁹⁰Zr with a half-life of 64.1 hours. All of the ⁹⁰Sr decays to the ground state of ⁹⁰Y. ⁹⁰Y has a relatively complicated decay scheme but most decays are to the ground state of ⁹⁰Zr with a small branching ratio to an excited state which can be ignored [11]. Figure 3 shows the complete double decay scheme of ⁹⁰Sr. The source is small enough to be regarded as a point source and contained inside a brass cylinder thick enough to prevent beta particles from penetrating. The cylinder has a 1mm × 6mm rectangular hole on the bottom side. The distance from the source to the hole is 40mm, so that only nearly vertical electrons to the silicon pad detector plane can pass the hole. The electrons from the decays of 90 Y to the ground state of 90 Zr have its maximum kinetic energy of 2281.4keV. This is the electron used in the tests. The 64.1 hour half-life of 90 Y is long enough to prevent accidental coincidences between beta particles from 90 Zr and 90 Y. A 2.28MeV electron has a range in Si around 5mm (5000 μ m). Using a Monte Carlo simulation, we have checked that the high energy portion of the electrons from 90 Y can mimic the energy loss of a minimum ionizing particle in the silicon pad detector.

C. Triggering scintillators and the test stand geometry

Although electrons from ⁹⁰Sr can penetrate all the elements including the silicon detector, its supporting material, and the two scintillation fibers, their energy is still not high enough to be free from a large angle deflection when they pass through materials. There is spurious crosstalk due to this beta particle deflection effect, and for the accurate crosstalk measurement it is necessary to select only the electrons which penetrate the silicon pad detector with a small deflection angle. Figure 4 shows our test stand geometry. The triggering scintillators are composed of two $2\text{mm} \times 2\text{mm} \times 25\text{mm}$ scintillating fibers and a $25\text{mm} \times 25\text{mm} \times 12.5\text{mm}$ plastic scintillator. Two fibers are configured as an "X" and they define the narrow incident angle of beta rays into an $\approx 2\text{mm} \times 2\text{mm}$ square. The plastic scintillator which is beneath the scintillation fibers is to discriminate against low energy beta particles which are more likely deflected into the large angle. This bottom scintillator is thick enough to stop any incident beta particles from the ⁹⁰Sr source.

The silicon pad detector is placed 25mm above the uppermost scintillation detector. The silicon pad detector is supported by a 2mm thick G10 circuit board, and the detector together with circuit board and FEE board are attached to the 15mm aluminum support. There are holes in the aluminum support around the tested silicon readout pads to avoid beta particle being absorbed by the thick aluminum support. The high energy portion of the electrons from the beta source have sufficient range to pass through the 300μ m silicon pad detector, the 2mm G10 circuit board, the two scintillating fibers, and then stop somewhere in the thick bottom plastic scintillator. The source is positioned 20mm above the silicon detector. There is no collimator except the hole on the brass source container.

All of the detectors and the source assembly are placed in a dark box, and the electronics, with the exception of the BVX preamplifier, are placed outside the dark box. The electronics are composed of NIM amplifiers, discriminators, coincidence units, and CAMAC digitizers. Because the BVX preamplifier is DC coupled, it is necessary to insert a capacitor between the preamplifier and the main NIM amplifier to measure the AC coupled signal. VME combined with a CAMAC system was used to read out the data.

III. MONTE CARLO SIMULATIONS

The purpose of the Monte Carlo simulation is to estimate the level of spurious crosstalk from the deflected beta particles and the relative counting rate of the test system. A beta particle can hit one channel of the pad detector(referred to here as a "primary channel"), followed by deflection, then hit a neighboring channel. This also is observed as crosstalk. It is necessary to estimate the level of such spurious crosstalk for the measurement of the real crosstalk in the silicon detector itself.

The GEANT code [12] was used in the simulation study. The cascaded decays of 90 Sr and 90 Y were simulated including the small branching ratio to the excited state of 90 Zr. Simple flat distributions from zero to the end point energy were used as both 90 Sr and 90 Y energy spectra. Figure 5 shows some results of the GEANT simulation. The beta particles from the 90 Sr source undergo significant deflection in the test setup. Table 1 shows the simulation result for the case of requiring two scintillating fibers for the trigger. The efficiency is defined as the ratio of electrons passing the trigger to electrons coming out of the source container. This trigger imposes a severe constraint on the incident angle due to the small overlap area(2mm × 2mm) of the two fibers. Unfortunately, this restriction degrades the counting efficiency. Among beta particles emerging from the source container, only 4.5×10^{-5} satisfy the trigger condition in the smallest pad channel. For large pads this fraction increases slightly to 1.6×10^{-4} . As can be seen in figure 5, the small efficiency is caused by multiple scattering of electrons, as well as by the ranging-out effect.

The simulation was repeated with the two scintillating fibers removed from the trigger condition in order to increase the counting efficiency. The trigger condition is then only simultaneous hits in the primary silicon channel and the plastic scintillator. Table 2 shows the results of this simulation. The efficiency was increased by more than a factor of 100. The spurious crosstalk in the neighboring channels is 0.19% and 0.09% in the 2.0mm × 2.0mm and 4.5mm × 4.5mm pad channels respectively. There was no spurious crosstalk between non-neighboring channels in any case.

IV. MEASUREMENT

A. Calibration

The external electronics outside the dark box were calibrated using a pulse generator. The same pulses were fed into the circuit just after the preamplifier. Using this calibration procedure, the external amplifier gains and the ADC slopes were obtained. In the next calibration step, the gain of the individual silicon pad detector plus the BVX preamplifier was measured. Beta particles were used to mimic minimum ionizing particles. ADC distributions for minimum ionizing particles were measured for each channel of the silicon pad detector. Table 3 shows the relative gains of the silicon pad detector plus BVX preamplifier for the eight channels used in the test. Gains for the pad detector and the preamplifier were not measured separately to avoid re-wirebonding the detector to front end electronics.

B. Setup

For the trigger using only the plastic scintillator and the primary pad channel, the simulation study showed the spurious crosstalk levels due to the electron scattering to be only 0.14% in the neighboring channel and 0.02% in the next neighboring channel. The discriminator thresholds for these two detectors were set just above the noise level. Figure 6 shows the block diagram of the electronics for the crosstalk measurement. The coincidence unit was set to have 1μ s resolving time. The accidental coincidence rate was checked by observing the timing pulses in a digital oscilloscope. No random timing fluctuation between the scintillator pulse and the pulse from the silicon pad detector was observed. This corresponded to the estimation of the accidental coincidence rate in our setup to be $1/\tau A\epsilon \approx$ 10^{-4} , where τ , A and ϵ represent the coincidence resolving time, the source strength and the counting efficiency respectively. This can be checked by looking at the ADC distribution of the primary channel(figure 7A). A high energy tail originating from the random coincidence of low energy electrons would show up as in figure 7(A) for the ADC distribution without trigger.

Simple amplifiers without any pulse shaping were used just to amplify the small signals from the preamplifiers because the preamplifier already shaped the pulse from the silicon detector. The preamplifier output has a risetime of 200ns. AC-coupling capacitors were inserted to remove the DC offsets from the silicon detector. Because our test system was relatively noisy and did not have any filtering device, the random noise level was expected to be larger or comparable to the crosstalk signal. Charge sensing ADCs(LeCroy 2249W) with 1μ s gate width were used to integrate all the crosstalk signal and noise.

C. Analysis and results

After illuminating one pad detector channel with the beta source, the eight wirebonded channels of the silicon detector were read out simultaneously. For each channel, 20,000 counts of data were taken with the pad detector being aligned with the source and the trigger counter. The same amount of data was taken after dislocating the pad detector from the electron path. The former data was for the crosstalk and the random noise, and the latter was for the random noise only. Thus the pure crosstalk level can be obtained after subtracting the latter data from the former one. This procedure was repeated for all eight silicon channels.

Figure 7 shows some sample of ADC distributions which was obtained after subtracting the "source off" data from the "source on" data. Figure 7A shows the ADC distribution of the primary pad channel for all signals passing its own discriminator cut and 7B shows a typical Landau distribution for the primary channel obtained after imposing the trigger condition utilizing the scintillator. The narrow peak near zero in figure 7A represents the noise distribution. Figure 7C shows the ADC distributions of the channels in the same column with the primary channel. Because the "source on" and the "source off" data were taken separately and thus completely uncorrelated with each other, the width of this distribution is mainly caused by noise distribution of "source on" and "source off" data. The individual noise level in table 4 was obtained by looking at ADC values in the "source off" data. The deviation of the mean value of the distribution in figure 7C and 7D from zero represents the crosstalk. As one can see in figure 7D, this shift was strikingly decreased in the channel of the different column from the primary channel.

The measurement showed that the crosstalk occurs along channels in the same column on which the read out traces run, and very small crosstalk occurs along the channels in the different column. The amount of the crosstalk levels in the small-sized pad channels (2.0mm \times 2.0mm and 2.5mm \times 2.5mm) were 2.1% in average when one of the small channels was chosen as a primary channel and 2.8% in average in the large-sized channels (4.0mm \times 4.0mm and 4.5mm \times 4.5mm) when one of the large channels was the primary channel. The crosstalk is bi-directional within a column. That is, the crosstalk between a pad near the bottom whose signal line crosses a pad above it in the same column is about the same when either of the pads is selected as the primary pad. Table 4 shows the results of crosstalk measurements for 8 wirebonded channels along with the noise levels of the primary channels. Except for the case of channel 2 which showed relatively large crosstalk levels, all the channels in different columns (channel #6, #7, and #8) showed crosstalk less than 1%(0.2% in average) when the small-sized pad channels were illuminated. When the large channels were illuminated, the small-sized channels in the different column exhibited the negative crosstalk without exception (-0.6% in average). If the crosstalk originates from the capacitance coupling between the pad silicon and the metal readout trace which runs over it, the crosstalk would occur in both directions in the same column and not occur in between pads in different columns because readout traces do not run over the silicon pad in the different column. Figure 8 shows some of the results graphically. Here the arrows represent the primary channels. As one can see in the figure there are clear patterns of the crosstalk: bi-directional in the same column and no major crosstalk in the different column. Since the capacitance is expected to be proportional to the length of the silicon pad, the crosstalk level would increase as the pad size increases. In our measurement, we observed this trend.

V. SUMMARY

A simple test stand for the crosstalk measurement of the silicon pad detector was made using a ⁹⁰Sr beta source and plastic scintillators. The Monte Carlo simulation study showed beta particles from the ⁹⁰Sr can mimic a minimum ionizing particle in such a test. The simulations also showed that the effect of the spurious crosstalk level by scattered electrons is negligible in the crosstalk measurement.

The measurements determined that the crosstalk level is 1.6% - 3.1%, which does not exceed our maximum allowed level of 7.8%. This proved the double-metal silicon pad detector can be used as a PHENIX MVD detector component. The major crosstalk occurred between the pair of pads in the same column – any pair of pads for which the readout trace of one pad crosses the other pad exhibits crosstalk – but not between different columns. The amount of the crosstalk between the small pads was about 2/3 of that between the large pads.

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FIGURES



FIG. 1. Picture of the silicon pad detector for the PHENIX MVD "endcaps".



FIG. 2. The pad channel numbering convention in this test.



FIG. 3. The decay scheme of 90 Sr.



FIG. 4. The test stand geometry.



FIG. 5. An example of the Monte Carlo simulation. 100 electrons were generated in this sample. The solid lines represent the trajectories of electrons and dotted lines represent the secondary bremsstrahlung photons.



FIG. 6. The block diagram for the electronics used in the test. +30V bias voltage was supplied to the silicon pad detector. Si^{*} represents the primary channel(channel illuminated by the source) and Si represents one of the neighboring channels. HV = high voltage supply, PP = preamplifier power supply, CFD = constant fraction discriminator, CU = coincidence unit, DL = delay line, PS = plastic scintillator, LFO = linear fan out, PA = preamplifier, and DGG = delay and gate generator.



FIG. 7. The ADC distributions. (A)the single spectrum for the primary channel. (B)primary channel. (C)neighboring channel(in the same column). (D)neighboring channels(in the different column).



FIG. 8. The results of the crosstalk measurement. Arrows represent the channels illuminated by the source.

TABLES

TABLE I. The Monte Carlo simulation results when the X shaped scintillation fibers are included in the trigger condition.

primary channel	$\#1(2.0\mathrm{mm} \times 2.0\mathrm{mm})$	$\#8(4.5 \text{mm} \times 4.5 \text{mm})$
crosstalk	0.00%(in channel #2)	0.00%(in channel #7)
crosstalk	0.00%(in channel #3)	0.00%(in channel #6)
efficiency	4.5×10^{-5}	1.6×10^{-4}

primary channel	$\#1(2.0\mathrm{mm} imes2.0\mathrm{mm})$	$\#8(4.5\mathrm{mm} \times 4.5\mathrm{mm})$
crosstalk	0.19%(in channel #2)	$0.09\%({\rm in~channel}~\#7)$
$\operatorname{crosstalk}$	0.00%(in channel #3)	0.00%(in channel #6)
efficiency	6.2×10^{-3}	1.9×10^{-2}

TABLE II. The Monte Carlo simulation results when the X shaped scintillation fibers are excluded in the trigger condition.

channel number	relative gain	channel number	relative gain
1	1.000 ± 0.003	5	1.033 ± 0.004
2	1.050 ± 0.004	6	1.003 ± 0.004
3	0.990 ± 0.004	7	0.925 ± 0.004
4	1.020 ± 0.004	8	0.951 ± 0.004

TABLE III. The relative gain of the silicon pad detector + BVX preamplifier.

channel number	$\mathrm{noise}/\mathrm{1MIP}(\%)$	channel number	$\mathrm{noise}/\mathrm{1MIP}(\%)$
1	3.49 ± 0.01	5	3.63 ± 0.01
2	3.42 ± 0.01	6	4.26 ± 0.02
3	3.81 ± 0.01	7	5.10 ± 0.02
4	3.55 ± 0.01	8	4.99 ± 0.02

 TABLE IV. The noise level of the silicon pad detector. "Noise" is defined as the rms width of

 the ADC (pedestal) distribution with no source pointed at the channel.

channel	$\mathrm{crosstalk}(\%)$	$\mathrm{crosstalk}(\%)$	$\mathrm{crosstalk}(\%)$	$\mathrm{crosstalk}(\%)$
1	primary channel	$2.87{\pm}0.07$	$1.83 {\pm} 0.05$	$1.89{\pm}0.06$
2	$2.09 {\pm} 0.06$	primary channel	$2.05{\pm}0.06$	$2.00{\pm}0.06$
3	$2.00{\pm}0.06$	$2.98{\pm}0.08$	primary channel	$2.07{\pm}0.06$
4	$1.97{\pm}0.06$	$2.73 {\pm} 0.07$	$1.87 {\pm} 0.06$	primary channel
5	$1.80{\pm}0.05$	$2.59{\pm}0.07$	$1.72 {\pm} 0.05$	$1.62{\pm}0.05$
6	$0.34{\pm}0.04$	$1.31{\pm}0.05$	$0.28 {\pm} 0.04$	$0.19{\pm}0.04$
7	$0.49 {\pm} 0.05$	$1.36{\pm}0.06$	$0.17 {\pm} 0.05$	$0.19{\pm}0.05$
8	$0.47 {\pm} 0.05$	$1.48 {\pm} 0.06$	$0.28 {\pm} 0.04$	$0.19{\pm}0.04$
1	$1.89 {\pm} 0.06$	$-0.75 {\pm} 0.04$	$-0.59 {\pm} 0.03$	$-0.47 {\pm} 0.03$
2	$1.99{\pm}0.06$	$-0.58 {\pm} 0.03$	$-0.43 {\pm} 0.03$	$-0.29 {\pm} 0.03$
3	$1.91{\pm}0.06$	$-0.81 {\pm} 0.04$	$-0.67 {\pm} 0.04$	-0.57 ± 0.04
4	$1.75 {\pm} 0.05$	$-0.84{\pm}0.04$	$-0.71 {\pm} 0.04$	$-0.64{\pm}0.03$
5	primary channel	$-0.84{\pm}0.04$	$-0.75 {\pm} 0.04$	$-0.57 {\pm} 0.03$
6	$0.00 {\pm} 0.04$	primary channel	$2.73 {\pm} 0.08$	$2.80{\pm}0.08$
7	$0.03 {\pm} 0.05$	$2.69{\pm}0.08$	primary channel	$3.11{\pm}0.09$
8	$0.18 {\pm} 0.05$	$2.66{\pm}0.08$	$3.03{\pm}0.08$	primary channel

TABLE V. The crosstalk level of the silicon pad detector.